TOSHIBA Transistor Silicon PNP Epitaxial Type (PCT Process)

2SA1905

High-Current Switching Applications.

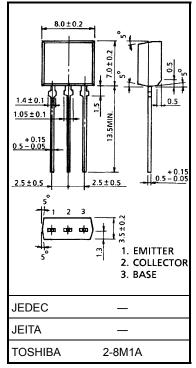
Unit: mm

- Low collector saturation voltage: $V_{CE (sat)} = -0.4 \text{ V (max)}$
- High speed switching time: $t_{stg} = 1.0 \mu s$ (typ.)
- Complementary to 2SC5076

Absolute Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Collector-base voltage	V _{CBO}	-60	٧
Collector-emitter voltage	V _{CEO}	-50	V
Emitter-base voltage	V _{EBO}	- 5	V
Collector current	IC	-5	Α
Base current	Ι _Β	-1	Α
Collector power dissipation	PC	1.3	W
Junction temperature	Tj	150	°C
Storage temperature range	T _{stg}	−55 to 150	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e.



Weight: 0.55 g (typ.)

operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

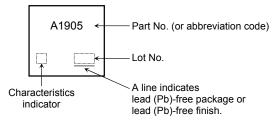


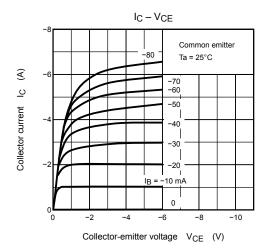
Electrical Characteristics (Ta = 25°C)

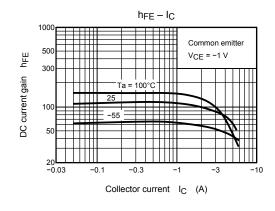
Chara	octeristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off c	urrent	I _{CBO}	V _{CB} = -50 V, I _E = 0	_	_	-1	μΑ
Emitter cut-off cur	rent	I _{EBO}	V _{EB} = -5 V, I _C = 0	_	_	-1	μA
Collector-emitter I	breakdown voltage	V (BR) CEO	$I_C = -10 \text{ mA}, I_B = 0$	-50	_	_	V
DC current gain		h _{FE (1)} (Note)	V _{CE} = -1 V, I _C = -1 A	70	_	240	
		h _{FE (2)}	V _{CE} = -1 V, I _C = -3 A	30	_	_	
Collector-emitter	saturation voltage	V _{CE (sat)}	I _C = -3 A, I _B = -0.15 A	_	-0.2	-0.4	V
Base-emitter satu	ration voltage	V _{BE (sat)}	I _C = -3 A, I _B = -0.15 A	_	-0.9	-1.2	V
Transition frequer	псу	f _T	V _{CE} = -4 V, I _C = -1 A	_	60	_	MHz
Collector output capacitance		C _{ob}	V _{CB} = -10 V, I _E = 0, f = 1 MHz	_	170	_	pF
Switching time Stor	Turn-on time	t _{on}	Output 20 μ s Input $\stackrel{B2}{\longrightarrow}$ $\stackrel{C}{\longrightarrow}$ $V_{CC} = -30 \text{ V}$ $V_{CC} = -30 \text{ V}$	_	0.1	_	
	Storage time	t _{stg}		_	1.0	_	μs
	Fall time	t _f		_	0.1	_	

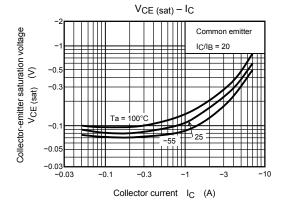
Note: $h_{FE\ (1)}$ classification O: 70 to 140, Y: 120 to 240

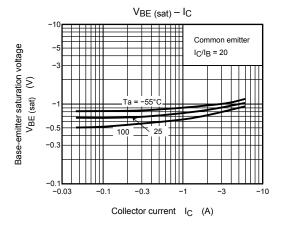
Marking

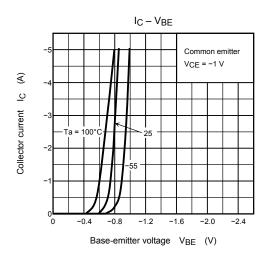




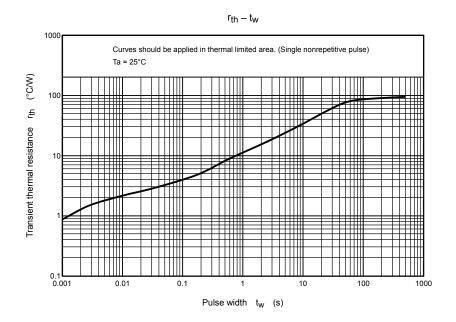


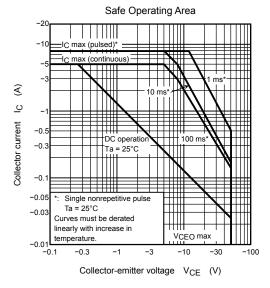


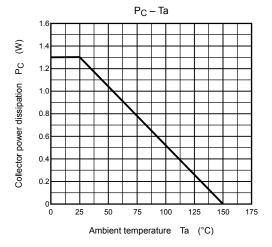




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